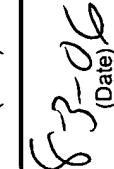
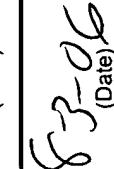
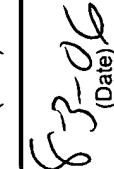
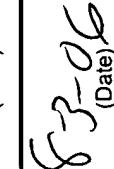


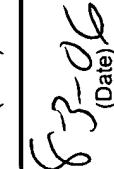
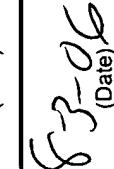
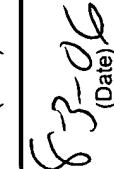
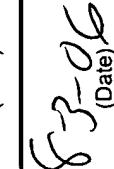
<b>Issue Classification</b>		Application/Control No. 10615186	Applicant(s)/Patent under Reexamination RAGAUSKAS, ARMINAS
		Examiner Apanius, Michael	Art Unit 3736
			

ORIGINAL		INTERNATIONAL CLASSIFICATION			
CLASS	SUBCLASS	CLAIMED			NON-CLAIMED
		A	6	1	
600	561	A	6	1	5 / 00
		A	6	1	5 / 103
<b>CROSS REFERENCE(S)</b>					
SUBCLASS (ONE SUBCLASS PER BLOCK)					
CLASS	587				
600					

  
  
**MAX F. HINDENBURG**  
 SUPERVISORY PATENT EXAMINER  
 TECHNOLOGY CENTER 3700
 

 <b>Michael Apanius</b> (Assistant Examiner)	 <b>Max F. Hindenburg</b> SUPERVISORY PATENT EXAMINER
 <b>Michael Apanius</b> (Legal Instruments Examiner)	 <b>Max F. Hindenburg</b> SUPERVISORY PATENT EXAMINER

**Total Claims Allowed:**  
**12**

 <b>Michael Apanius</b> (Primary Examiner)	 <b>Max F. Hindenburg</b> SUPERVISORY PATENT EXAMINER
 <b>Michael Apanius</b> (Primary Examiner)	 <b>Max F. Hindenburg</b> SUPERVISORY PATENT EXAMINER

**O.G.**  
**Print Claim(s)**  
**13**

**O.G.**  
**Print Figure**  
**2B**

**Date**  
**8/3/06**

**Date**  
**8/3/06**